Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	_
09/886,064	HAITSMA ET AL.	
Examiner	Art Unit	
Shin-Hon Chen	2131	

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Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search)	7/12/2006	S.C.
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